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FDMC86184 N-Channel Shielded Gate PowerTrench[®] MOSFET 100 V, 57 A, 8.5 m Ω

Features

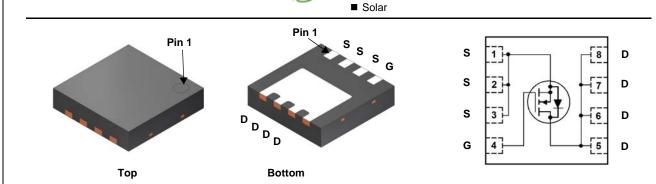
- Shielded Gate MOSFET Technology
- Max $r_{DS(on)} = 8.5 \text{ m}\Omega \text{ at } V_{GS} = 10 \text{ V}, I_D = 21 \text{ A}$
- Max $r_{DS(on)}$ = 24.8 m Ω at V_{GS} = 6 V, I_D = 10 A
- 50% Lower Qrr than Other MOSFET Suppliers
- Lowers Switching Noise/EMI
- MSL1 Robust Package Design
- 100% UIL Tested
- RoHS Compliant

General Description

This N-Channel MV MOSFET is produced using ON Semiconductor's advanced PowerTrench[®] process that incorporates Shielded Gate technology. This process has been optimized to minimize on-state resistance and yet maintain superior switching performance with best in class soft body diode.

Applications

- Primary DC-DC MOSFET
- Synchronous Rectifier in DC-DC and AC-DC
- Motor Drive



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted.

Symbol	Parameter Drain to Source Voltage			Ratings	Units	
V _{DS}				100	V	
V _{GS}	Gate to Source Voltage			±20	V	
ID	Drain Current -Continuous	T _C = 25 °C	(Note 5)	57		
	-Continuous	T _C = 100 °C	(Note 5)	36	•	
	-Continuous	T _A = 25 °C	(Note 1a)	12	A	
	-Pulsed		(Note 4)	266		
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	121	mJ	
P _D	Power Dissipation	T _C = 25 °C		54	14/	
	Power Dissipation	T _A = 25 °C	(Note 1a)	2.3	W	
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C	

Thermal Characteristics

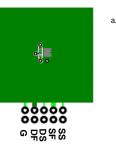
R_{\thetaJC}	Thermal Resistance, Junction to Case	2.3	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient (Note 1a) 53	C/VV

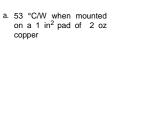
Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC86184	FDMC86184	Power 33	13 "	12 mm	3000 units

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Chara	octeristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	100		1	V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		59		mV/°C
IDSS	Zero Gate Voltage Drain Current	V _{DS} = 80 V, V _{GS} = 0 V			1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			100	nA
On Chara	cteristics					
V _{GS(th)}	Gate to Source Threshold Voltage	V _{GS} = V _{DS} , I _D = 110 μA	2.0	3.1	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_{I}}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 110 \ \mu\text{A}$, referenced to 25 °C		-9		mV/°C
5		V _{GS} = 10 V, I _D = 21 A		6.4	8.5	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 6 \text{ V}, I_D = 10 \text{ A}$		11	24.8	mΩ
		V _{GS} = 10 V, I _D = 21 A, T _J = 125 °C		11	18	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 21 A		49		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz		1490	2090	pF
C _{oss}	Output Capacitance			906	1270	pF
C _{rss}	Reverse Transfer Capacitance			13	25	pF
R _g	Gate Resistance		0.1	0.4	1.2	Ω
Switching	g Characteristics					
t _{d(on)}	Turn-On Delay Time			12	22	ns
t _r	Rise Time	V _{DD} = 50 V, I _D = 21 A,		4	10	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10 V, R_{GEN} = 6 Ω		17	31	ns
t _f	Fall Time			4	10	ns
Qg	Total Gate Charge	$V_{GS} = 0 V$ to 10 V		21	30	nC
Qg	Total Gate Charge	$V_{GS} = 0 V$ to $6 V$ $V_{DD} = 50 V$,		14	20	nC
Q _{gs}	Gate to Source Charge	I _D = 21 A		6.5		nC
Q _{gd}	Gate to Drain "Miller" Charge			4.6		nC
Q _{oss}	Output Charge	$V_{DD} = 50 \text{ V}, V_{GS} = 0 \text{ V}$		61		nC
ວrain-Soເ	urce Diode Characteristics					
		$V_{GS} = 0 V, I_S = 2.1 A$ (Note 2)		0.7	1.2	
V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 21 A$ (Note 2)		0.8	1.3	V
t _{rr}	Reverse Recovery Time			27	44	ns
Q _{rr}	Reverse Recovery Charge	$I_{\rm F} = 10 \text{ A}, {\rm di/dt} = 300 {\rm A/\mu s}$		46	74	nC
t _{rr}	Reverse Recovery Time			21	34	ns
Q _{rr}	Reverse Recovery Charge	—I _F = 10 A, di/dt = 1000 A/μs		96	154	nC

1. R_{0,JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0CA} is determined by the user's board design.

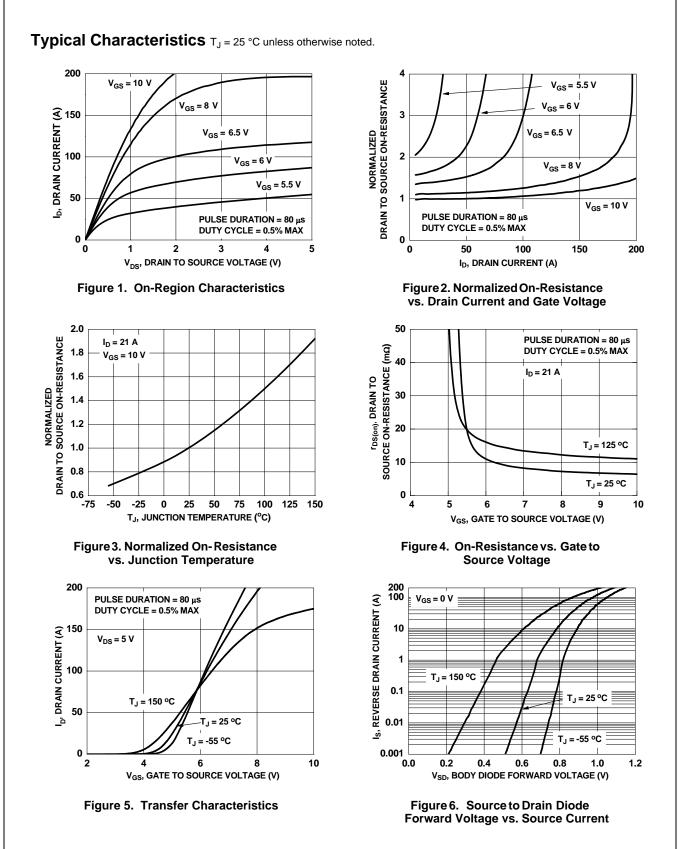




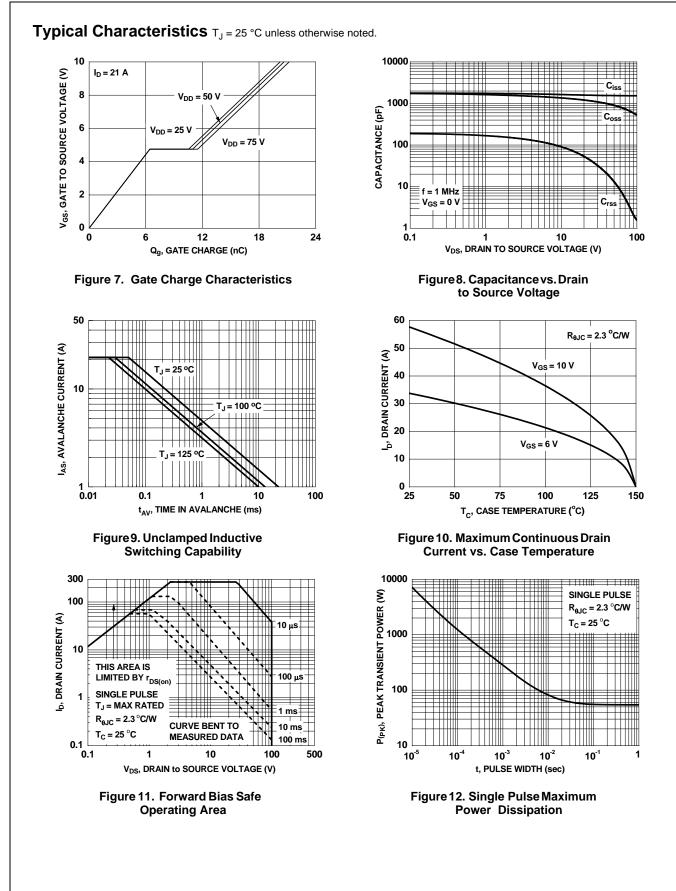
b. 125 °C/W when mounted on a minimum pad of 2 oz copper

Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.
E_{AS} of 121 mJ is based on starting T_J = 25 °C; N-ch: L = 3 mH, I_{AS} = 9 A, V_{DD} = 100 V, V_{GS} =10 V. 100% test at L = 0.3 mH, I_{AS} = 21 A.
Pulsed Id please refer to Fig 11 SOA graph for more details.
Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

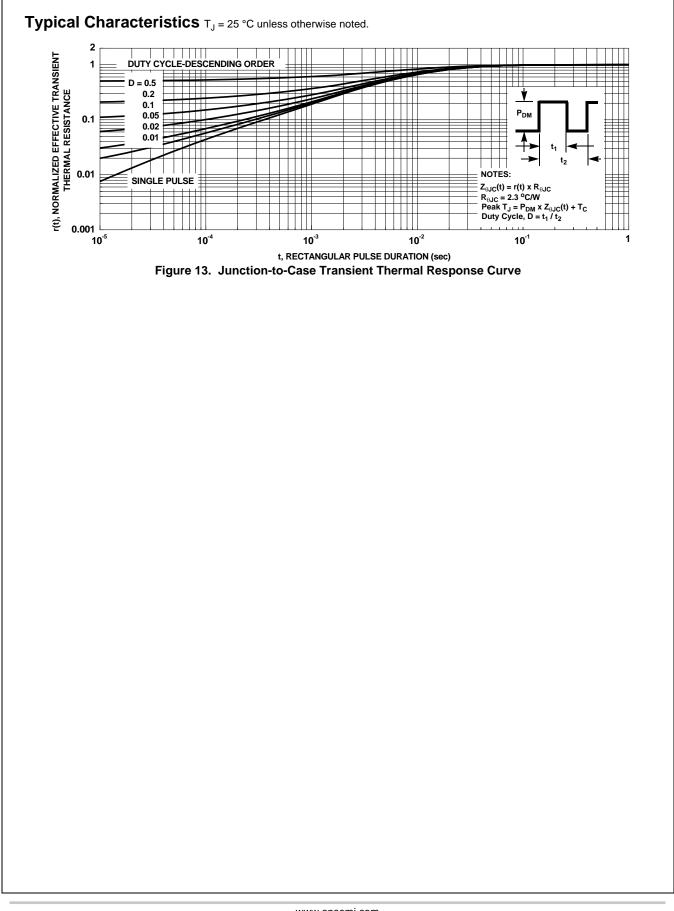
o PDS S

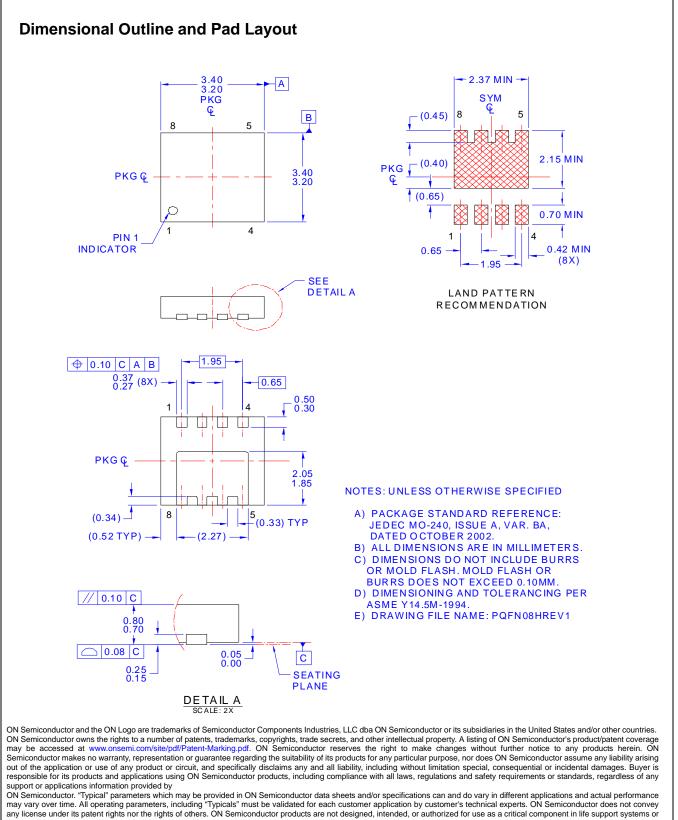






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